

## Small, Single-/Multi-Cell Solar Harvester with MPPT and Harvest Counter

**MAX20361**

### General Description

The MAX20361 is a fully integrated solution for harvesting energy from single-/multi-cell solar sources. The device includes an ultra-low quiescent current (360nA) boost converter that is capable of starting from input voltages as low as 225mV (typ). In order to maximize the power extracted from the source, the MAX20361 implements a proprietary maximum power point tracking (MPPT) technique that allows efficient harvesting from 15 $\mu$ W to over 300mW of available input power.

The MAX20361 also features an integrated charging and protection circuit that is optimized for Li-ion batteries, but can also be used to charge supercapacitors, thin-film batteries, or traditional capacitors. The charger features a programmable charging cut-off voltage with thresholds programmable through I<sup>2</sup>C interface as well as temperature shutoff.

The MAX20361 is available in a 12-bump, 0.4mm pitch, 1.63mm x 1.23mm wafer-level package (WLP).

### Applications

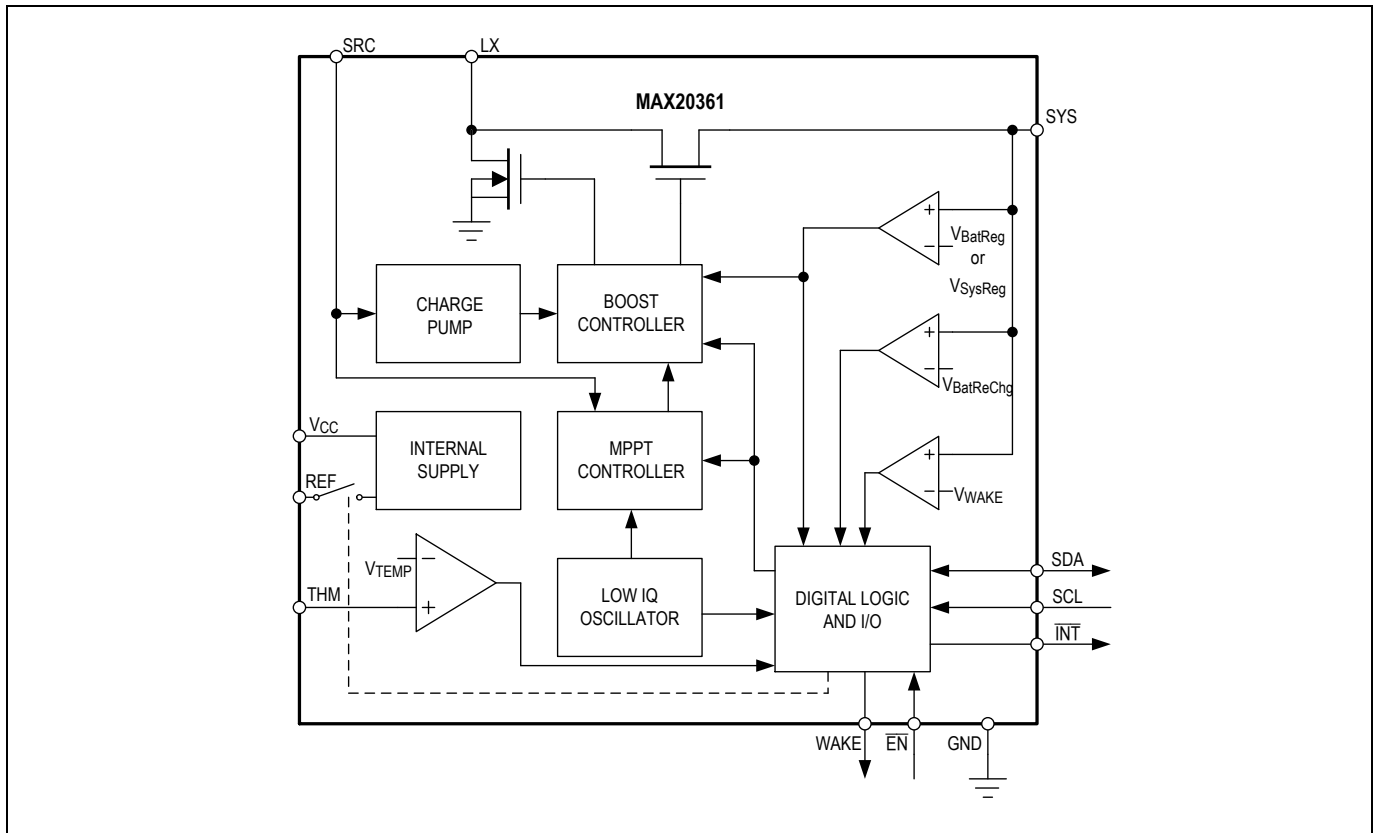
- Wearable Fitness
- Medical Devices
- Industrial IoT Sensors
- Asset Tracking Devices
- Wireless Sensor Networks

### Benefits and Features

- Single-/Multi-Cell Solar Energy Harvester
  - 225mV to 2.5V (typ) Input-Voltage Range
  - Efficient Harvesting from 15 $\mu$ W to Over 300mW of Available Input Power
    - 86% Efficiency at  $V_{SYS} = 3.8V$ ,  $I_{SRC} = 30mA$
  - Small Solution Size
    - Utilizes Small 2016 4.7 $\mu$ H Inductor
- Maximum Power Point Tracking (MPPT) Technique Using Fractional VOC Method
  - Programmable Fractional VOC Regulation Point through I<sup>2</sup>C Interface
- Battery/Supercapacitor Charger
  - Programmable Battery Termination Voltage through I<sup>2</sup>C Interface
  - Programmable Power Good Wake-Up Signal Output Threshold through I<sup>2</sup>C Interface

**Ordering Information appears at end of datasheet**

Simplified Block Diagram



**Absolute Maximum Ratings**

SYS, V <sub>CC</sub> to GND .....	-0.3V to +6V	Continuous Current into any other Pin .....	-0.05A to +0.05A
SRC to GND .....	-0.3V to +3.5V	Continuous Power Dissipation (Multilayer Board) (T <sub>A</sub> = +70°C, derate 13.73mW/°C above +70°C) .....	1098.4mW
$\overline{\text{INT}}$ , $\overline{\text{EN}}$ , SDA, SCL to GND.....	-0.3V to +6V	Operating Temperature Range .....	-40°C to +85°C
WAKE to GND.....	-0.3V to (SYS + 0.3V)	Junction Temperature Range.....	-40°C to +150°C
REF, THM to GND.....	-0.3V to (V <sub>CC</sub> + 0.3V)	Storage Temperature Range .....	-40°C to +150°C
LX to GND .....	-0.3V to (V <sub>CC</sub> + 0.3V)	Soldering Temperature (reflow).....	+260°C
Continuous Current into LX, GND or SYS .....	-0.5A to +0.5A		

*Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*

**Package Information**

**12-WLP**

Package Code	W121C1+2
Outline Number	<a href="#">21-100426</a>
Land Pattern Number	Refer to <a href="#">Application Note 1891</a>
<b>THERMAL RESISTANCE, FOUR LAYER BOARD</b>	
Junction-to-Ambient (θ <sub>JA</sub> )	72.82°C/W

For the latest package outline information and land patterns (footprints), go to [www.maximintegrated.com/packages](http://www.maximintegrated.com/packages). Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to [www.maximintegrated.com/thermal-tutorial](http://www.maximintegrated.com/thermal-tutorial).

## Electrical Characteristics

( $V_{SYS} = +3.0V$  to  $+4.2V$ ,  $V_{SRC} = +0.3V$  to  $+2.5V$ , typical value is at  $V_{SYS} = +3.8V$ ,  $V_{SRC} = +0.6V$ ,  $T_A = +25^\circ C$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
<b>SUPPLY</b>						
SYS Shutdown Supply Current	$I_{SYS\_SHDN}$	DeviceEnb = 1, any $V_{SRC}$		190	650	nA
SYS Sleep Supply Current	$I_{SYS\_SLEEP}$	DeviceEnb = 0, $V_{SRC} = 0V$		360	1200	nA
SYS Idle Supply Current	$I_{SYS\_IDLE}$	$\overline{EN} = 0V$ , boost not switching, not in sleep mode		1.43		$\mu A$
<b>SYSTEM CONTROL (SYS)</b>						
System Termination Voltage-Programmable Range	$V_{SYS\_REG}$	50mV steps, programmable through I <sup>2</sup> C		4 to 4.7		V
System Regulation-Voltage Accuracy	$V_{SYS\_REG\_ACC}$	$T_A = 0^\circ C$ to $+60^\circ C$ SysReg[3:0] = 7, SYS rising	-1		+1	%
WAKE Voltage-Programmable Range	$V_{WAKE\_RANGE}$	100mV steps, programmable through I <sup>2</sup> C		3 to 3.7		V
WAKE Voltage Accuracy	$V_{WAKE\_ACC}$	WakeThr[2:0] = 0, SYS rising	-2		+2	%
WAKE Debounce Time	$t_{WAKE\_TDEB}$		7 x $T_{meas}$		8 x $T_{meas}$	ms
<b>BOOST REGULATOR</b>						
Input Operating Voltage at SRC	$V_{SRC\_RANGE}$		0		2.5	V
Minimum Cold-Start Voltage	$V_{SC}$	$T_A = 25^\circ C$ (Note 3)		225	350	mV
Efficiency	BOOST_EFF	$V_{SRC} = 0.75V$ , $V_{SYS} = 3.8V$ , $I_{SRC} = 100\mu A$ , $L = 4.7\mu H$ , DFE201612E-4R7M = P2 Series Inductor		77		%
		$V_{SRC} = 0.75V$ , $V_{SYS} = 3.8V$ , $I_{SRC} = 30mA$ , $L = 4.7\mu H$ , DFE201612E-4R7M = P2 Series Inductor		86		
LX Low-Side On Resistance	$R_{ON\_LXL}$			0.1	0.14	$\Omega$
LX SYS High-Side On Resistance	$R_{ON\_LX\_SYS}$			0.29	0.39	$\Omega$
SRC LX Slow Snubber Resistance	$R_{LX\_SSNUB}$			20		k $\Omega$
SRC LX Snubber Resistance	$R_{LX\_SNUB}$			342		$\Omega$
Peak Current	$I_{BSTpk0}$			90		mA
	$I_{BSTpk1}$			120		
	$I_{BSTpk2}$			145		
	$I_{BSTpk3}$			180		
	$I_{BSTpk4}$			285		
	$I_{BSTpk5}$			355		
	$I_{BSTpk6}$			470		
	$I_{BSTpk7}$			715		
<b>SRC METER</b>						

(V<sub>SYS</sub> = +3.0V to +4.2V, V<sub>SRC</sub> = +0.3V to +2.5V, typical value is at V<sub>SYS</sub> = +3.8V, V<sub>SRC</sub> = +0.6V, T<sub>A</sub> = +25°C.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
SRC DAC Full-Scale	V <sub>DACFS</sub>	SRC equivalent voltage			2.595		V
SRC Leakage	I <sub>LNKSR</sub>	V <sub>SRC</sub> = 1V			0.75		μA
<b>MAXIMUM POWER POINT TRACKING</b>							
Fractional Open Circuit Voltage-Programmable Range	V <sub>FRAC_VOC_P</sub>	1.5% steps, programmable through I <sup>2</sup> C			42.5 to 89.0		%
Error of Fractional VOC Regulation Point	V <sub>FRAC_VOC_E</sub> RROR	V <sub>SRC</sub> = 0.6V, includes measurement error of VOC and input voltage regulation error, excludes SRC ripple (Note 3)	VOC[7:0] = 75, Frac[4:0] = 25, BSTpk = 3, I <sub>SRC</sub> = 1mA	-4.7		+4.7	%
Open Circuit Measurement Period	t <sub>FRAC_VOC</sub>	ATper = 0, Tper = 00, see text			64 *		s
		ATper = 0, Tper = 01, see text			128 *		
		ATper = 0, Tper = 10, see text			256 *		
Open Circuit Measurement Settling Time	t <sub>FRAC_VOC_S</sub> ETTLE	ATmeas = 0, Tmeas = 00, see text			50		ms
		ATmeas = 0, Tmeas = 01, see text			100		
		ATmeas = 0, Tmeas = 10, see text			250		
		ATmeas = 0, Tmeas = 11, see text			500		
<b>EN</b>							
EN Input Threshold	V <sub>IENB</sub>					0.4	V
	V <sub>IHENB</sub>			1.0			
EN Input Resistance	R <sub>ENB</sub>			0.7	1	1.3	MΩ
<b>SCL, SDA, INT</b>							
SDA and INT Output-Low Voltage	V <sub>OLSDA</sub> , V <sub>OLINT</sub>	I = 5mA				0.3	V
SDA, SCL, INT Input Current	I <sub>SDA</sub> , I <sub>SCL</sub> , I <sub>INT</sub>	V <sub>-</sub> from 0V to 5.5V		-1	0	+1	μA
<b>WAKE</b>							
WAKE Output-Low Voltage	V <sub>OLWAKE</sub>	I = 5mA				0.3	V
WAKE Output-High Voltage	V <sub>OHWAKE</sub>	I = -5mA		SYS - 0.3			V
<b>THERMAL MONITORING (REF, THM)</b>							
REF Voltage	V <sub>REF</sub>	I <sub>REF</sub> from 0μA to 100μA		1.15	1.2	1.25	V
Cold Temperature Trip-Point Programmable Range	V <sub>COLD</sub>			53.5	57.5	60	%V <sub>REF</sub>
Hot Temperature Trip-Point Programmable Range	V <sub>HOT</sub>			16.2	18.7	22	%V <sub>REF</sub>
THM Input Leakage	I <sub>THM</sub>			-1		+1	μA
<b>I<sup>2</sup>C INTERFACE</b>							

( $V_{SYS} = +3.0V$  to  $+4.2V$ ,  $V_{SRC} = +0.3V$  to  $+2.5V$ , typical value is at  $V_{SYS} = +3.8V$ ,  $V_{SRC} = +0.6V$ ,  $T_A = +25^{\circ}C$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
SCL and SDA Input Threshold	$V_{IL}$				0.4	V
	$V_{IH}$		1			
<b>I<sup>2</sup>C TIMINGS</b>						
Serial Operating Frequency	$f_{SCL}$				400	kHz
Maximum Clock Period	$t_{SCLMAX}$		2.5			$\mu s$
START Condition Hold Time	$t_{HD:STA}$		0.6			$\mu s$
Clock Low Period	$t_{LOW}$		1.3			$\mu s$
Clock High Period	$t_{HIGH}$		0.6			$\mu s$
START Condition Setup Time	$t_{SU:STA}$		0.6			$\mu s$
Repeat START Condition Setup Time	$t_{SU:STA}$		0.6			$\mu s$
Data Hold Time	$t_{HD:DAT}$				0	ns
Data Valid to SCL Rise Time	$t_{SU:DAT}$		100			ns
STOP Condition Setup Time	$t_{SU:STO}$		0.6			$\mu s$
Bus Free Time Between STOP and START Conditions	$t_{BUF}$		1.3			$\mu s$

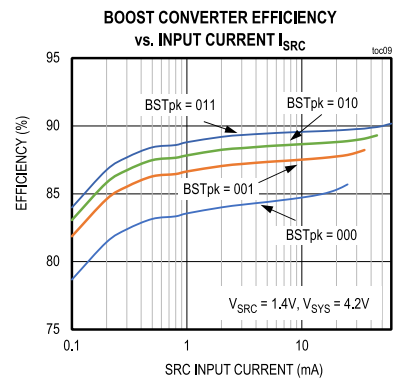
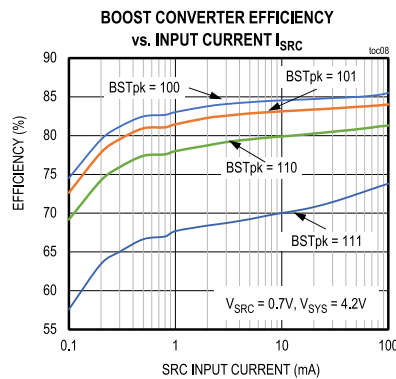
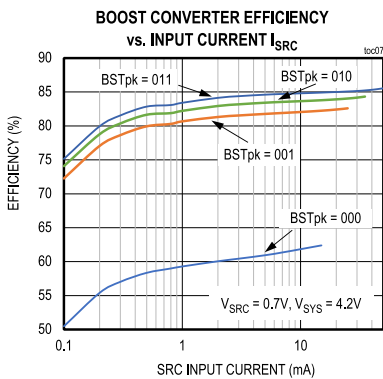
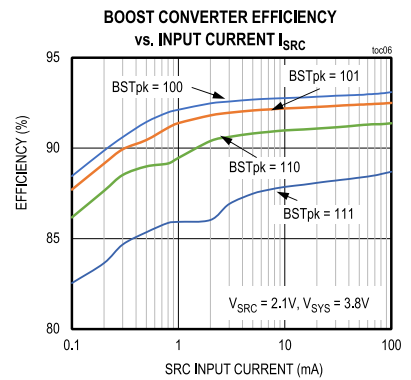
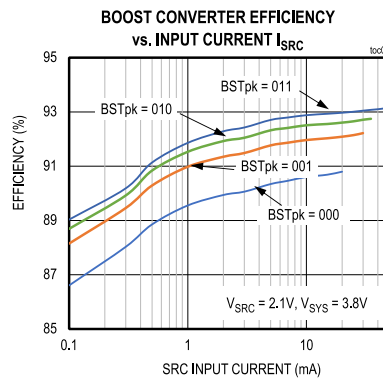
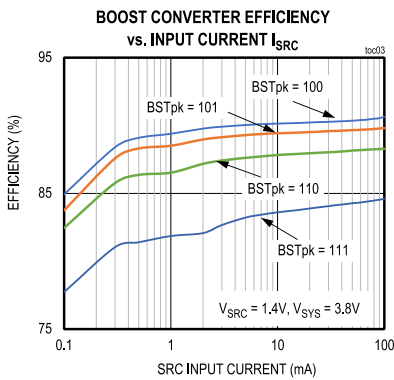
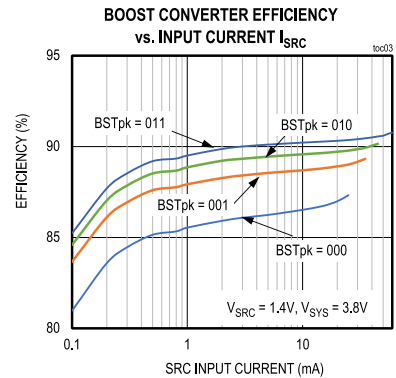
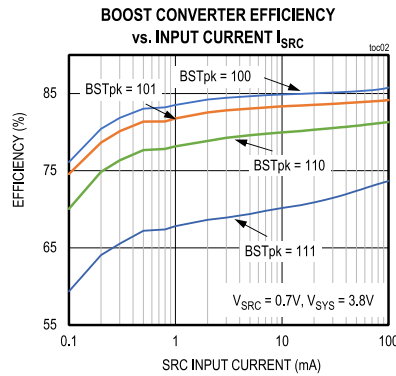
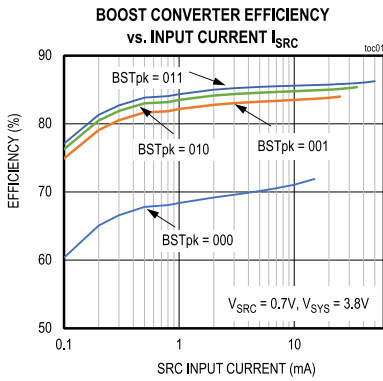
**Note 1:** All devices 100% productions tested at 25°C. Limits over the operating temperature range are guaranteed by design.

**Note 2:** All capacitance values listed in this document refer to effective capacitance. Be sure to specify capacitors that meets these requirements under typical system operating conditions, taking into consideration the effects of voltage and temperature.

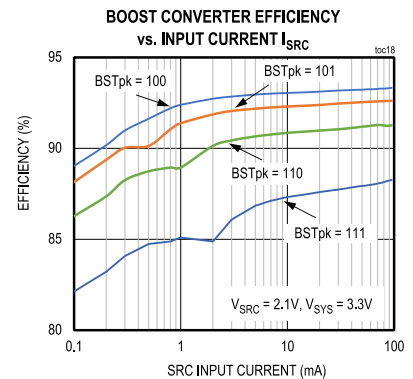
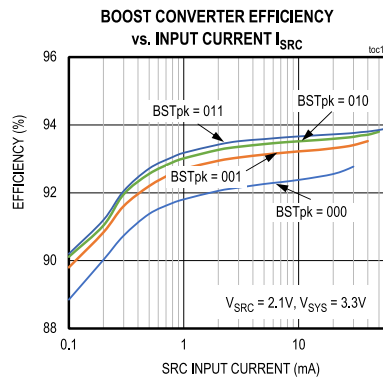
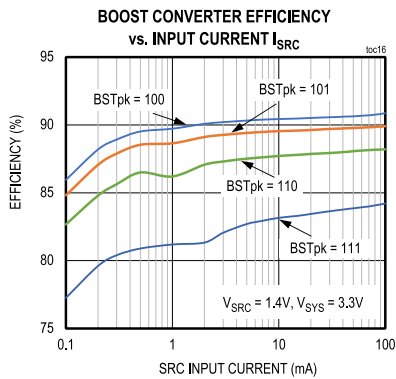
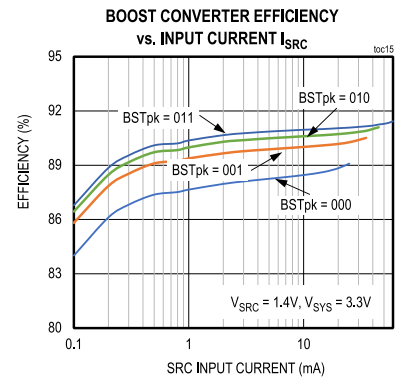
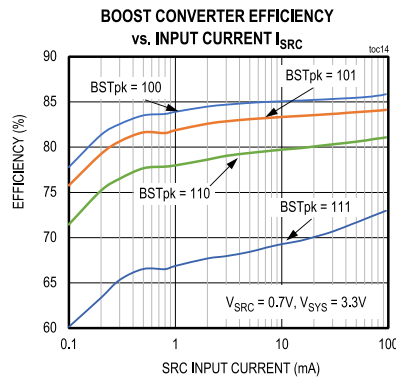
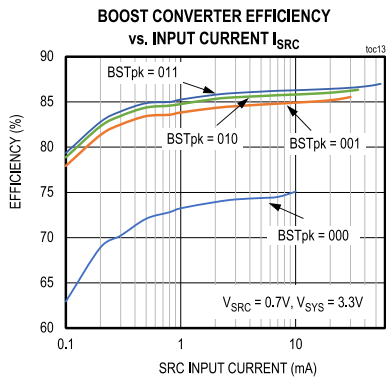
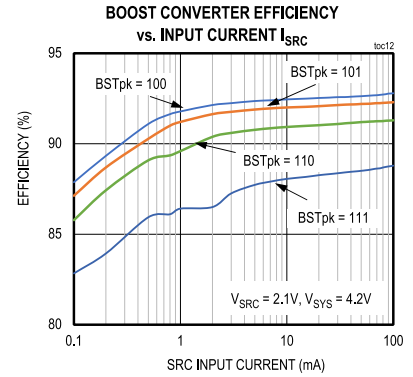
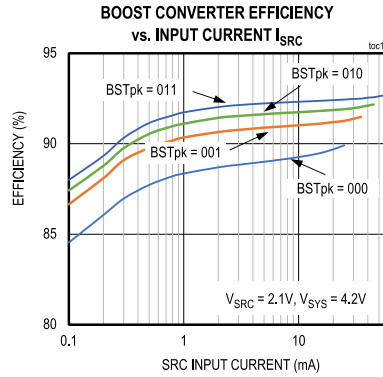
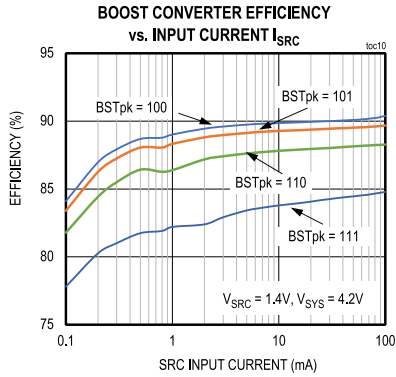
**Note 3:** Not production tested. Guaranteed by design.

Typical Operating Characteristics

( $T_A = 25^\circ\text{C}$ , unless otherwise noted.)

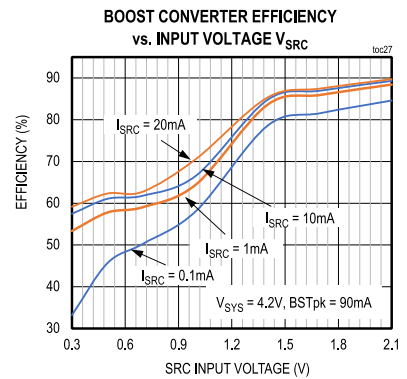
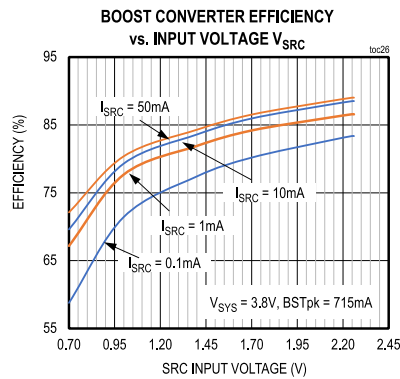
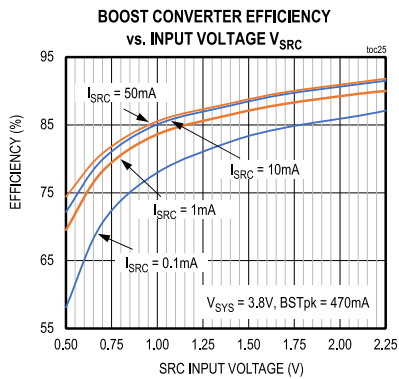
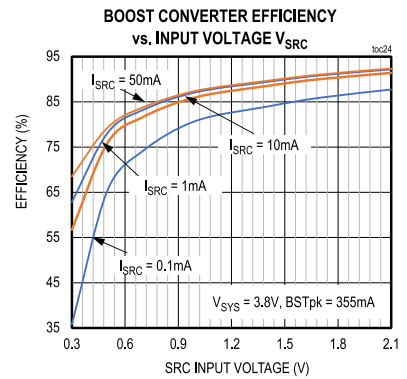
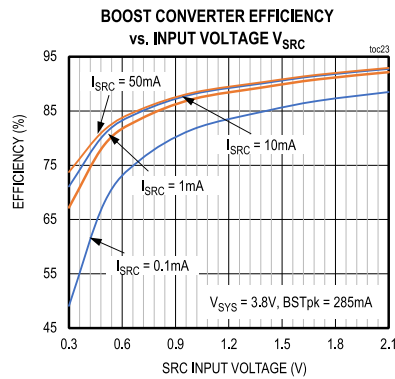
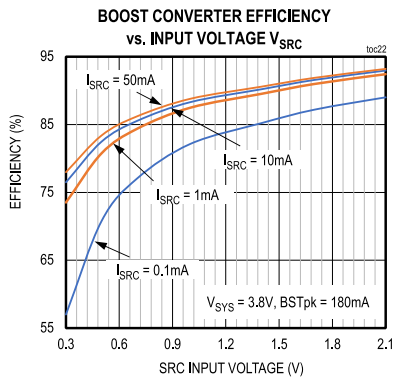
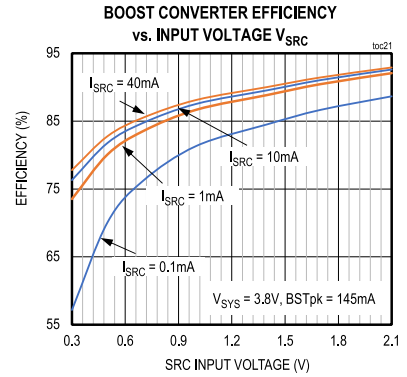
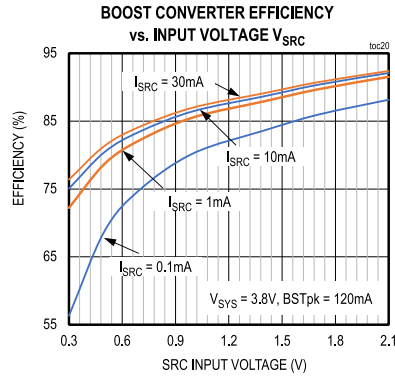
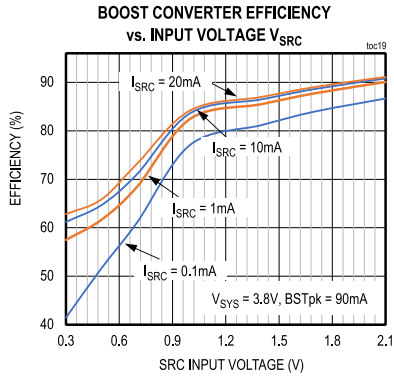


( $T_A = 25^\circ\text{C}$ , unless otherwise noted.)

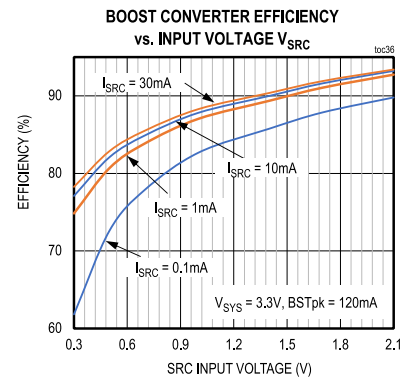
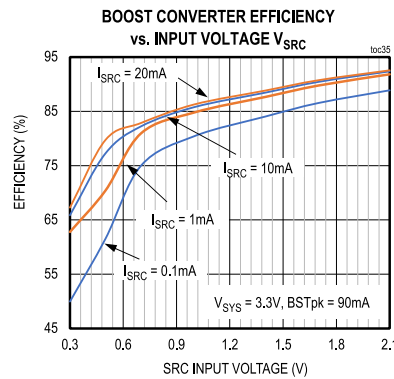
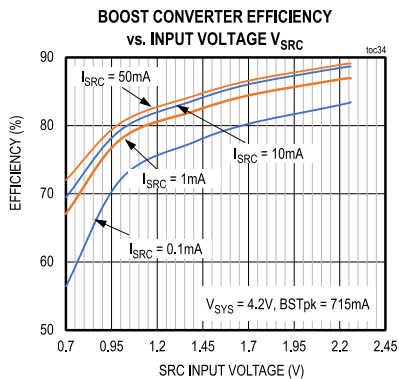
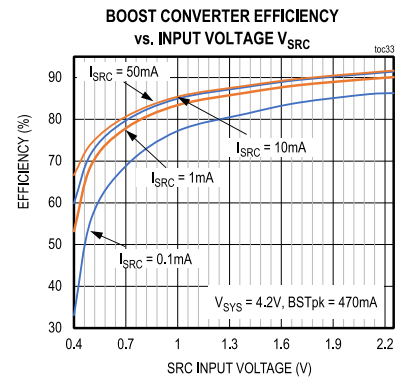
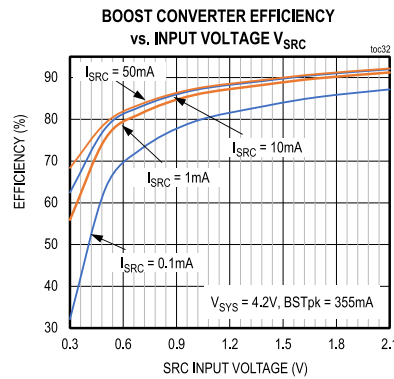
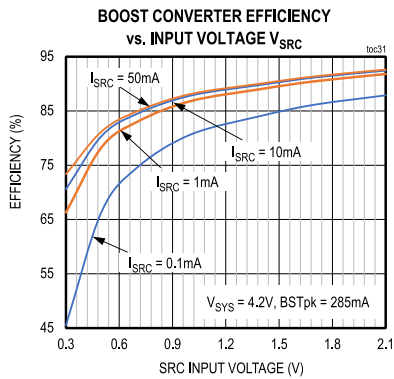
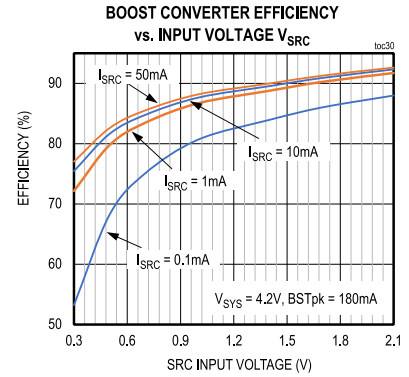
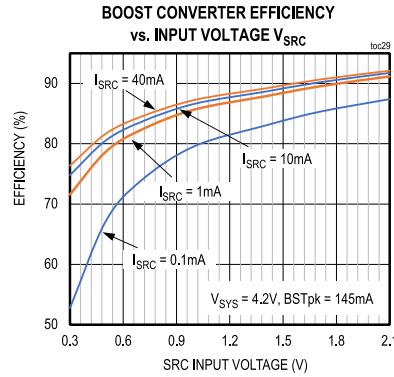
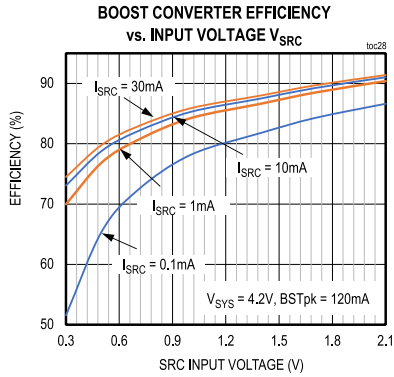




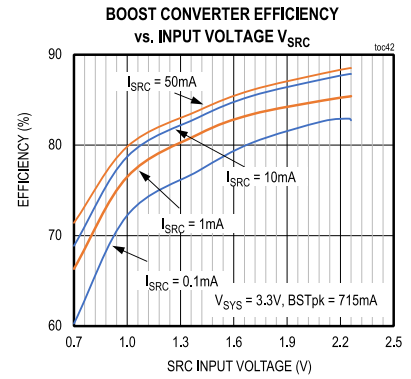
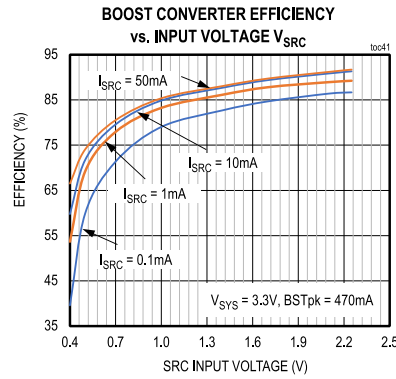
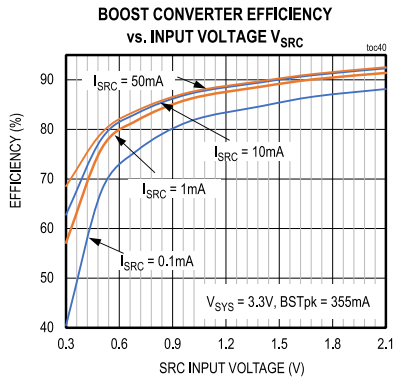
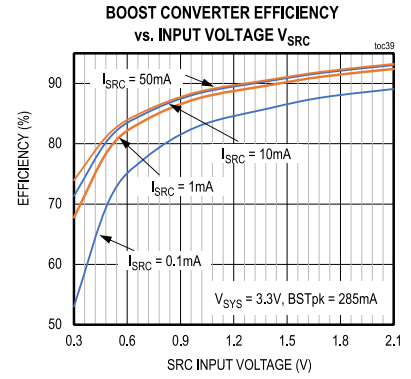
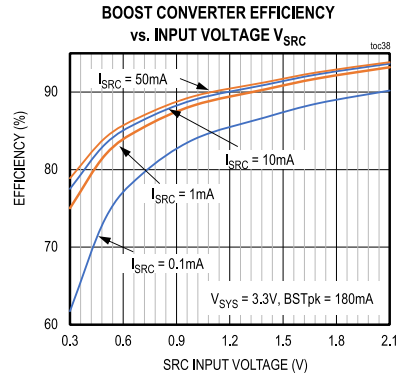
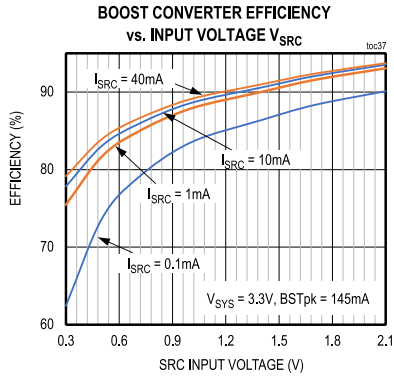
( $T_A = 25^\circ\text{C}$ , unless otherwise noted.)



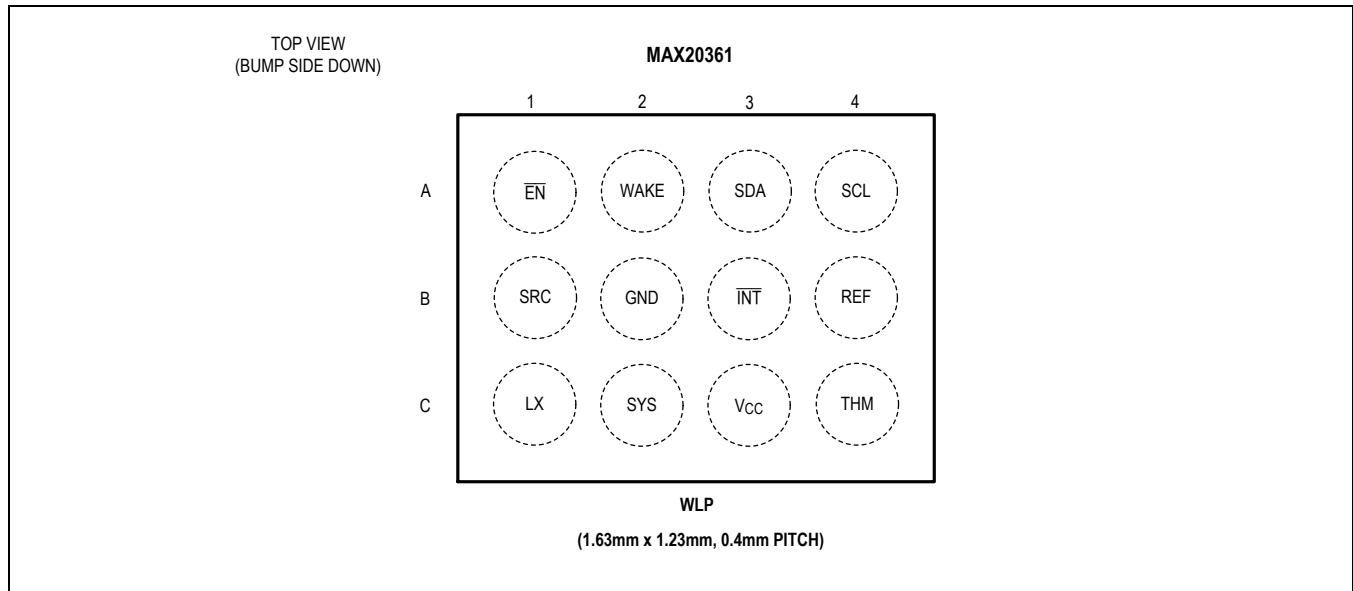
( $T_A = 25^\circ\text{C}$ , unless otherwise noted.)



( $T_A = 25^\circ\text{C}$ , unless otherwise noted.)



## Bump Configuration



## Pin Descriptions

PIN	NAME	FUNCTION
A1	$\overline{\text{EN}}$	Active Low Enable Input. When $\overline{\text{EN}}$ is high the device stops switching and enters a low power state. $\overline{\text{EN}}$ is internally pulled down to GND by a 1M $\Omega$ resistor. In the shutdown state, I <sup>2</sup> C is still operational.
A2	WAKE	Wake Signal for System MCU. This push-pull output is asserted when SYS is above WakeThr[2:0] and the device is not in sleep mode.
A3	SDA	I <sup>2</sup> C Serial Data
A4	SCL	I <sup>2</sup> C Serial Clock
B1	SRC	Source Input. Connect the harvesting source power output to SRC. Connect a 10 $\mu\text{F}$ capacitor between SRC and GND.
B2	GND	Ground
B3	$\overline{\text{INT}}$	Open-Drain Interrupt Output
B4	REF	Internal-Voltage Reference
C1	LX	Boost-Converter Switching Node. Connect a 4.7 $\mu\text{H}$ inductor between LX and the harvesting source power output (e.g., anode of solar cell).
C2	SYS	System Output. Connect to system input of power management IC. Connect a 1 $\mu\text{F}$ bypass capacitor between SYS and GND.
C3	$V_{\text{CC}}$	Internal Supply. Connect a 1 $\mu\text{F}$ bypass capacitor between $V_{\text{CC}}$ and GND.
C4	THM	Thermistor Input. Connect THM to a voltage divider formed by a pullup resistor and a pulldown thermistor.

## Detailed Description

The MAX20361 is a fully integrated solution for harvesting energy from single-/multi-cell solar sources. The device includes an ultra-low quiescent-current boost converter that is capable of starting from input voltage as low as 225mV (typ). In order to maximize the power extracted from the source, the MAX20361 implements a proprietary maximum power point tracking (MPPT) technique that allows efficient harvesting from 15 $\mu$ W to over 300mW of available input power.

The MAX20361 also features an integrated charging and protection circuit that is optimized for Li-ion batteries, but can also be used to charge supercapacitors, thin-film batteries, or traditional capacitors. The charger features a programmable charging cut-off voltage with thresholds programmable through the I<sup>2</sup>C interface as well as temperature shutoff.

### Boost Converter

The MAX20361 boost converter is optimized to efficiently harvest energy from a single-/multi-cell solar source. The MAX20361 implements a boost converter, which collects the current from the low-voltage SRC input and transfers it to the higher-voltage SYS output.

The switching frequency is not fixed but changes with the SRC voltage, SYS voltage and inductance values. Each time the SRC voltage drops below its regulation point, the boost is halted. SRC capacitance is needed to reduce the SRC ripple, but its value is not critical for stability (see the [Applications Information](#) section for more details).

The SYS voltage is monitored and when it reaches the regulation point, the boost is halted to avoid overcharging of the the battery, or an overvoltage on the SYS node.

### Harvesting Meter

The MAX20361 reports the count of the switching cycles of the boost converter during the last Tmeas[5:4](0x07) time in the HarvCntH(0x0A) and HarvCntL(0x0B) registers. This “harvesting count” is proportional to the current harvested during that period. To avoid a false read, the update of HarvCntH and HarvCntL is inhibited if the boost was halted in the last Tmeas period due to thermal monitoring, open-circuit voltage measurement, SYS overvoltage detected, sleep mode or I<sup>2</sup>C commands.

Every time a new valid value of HarvCntH/L is loaded, the HARrdy[4](0x01) bit is set.

### Maximum Power Point Tracking (MPPT)

During normal operation, the MAX20361 automatically measures the open-circuit voltage and computes the optimal SRC voltage to transfer the maximum power from the solar cell. Every Tper[1:0](0x07) (by default 64 x Tmeas, with Tmeas = 50ms, every 3.2s), or when requested by I<sup>2</sup>C, the internal boost is halted for Tmeas[5:4](0x07) and the SRC voltage is measured with the internal 8-bit ADC.

The SRC regulation point is computed by multiplying the measured voltage at SRC by the Frac[4:0](0x06) field. At power-up, the MAX20361 regulates the SRC voltage at a level determined by the value of Frac[4:0] and the default value of VOC[7:0]. (For example, if Frac[4:0] is set to 80% and the default value of VOC[7:0] is 29 decimal, the SRC regulation voltage is 230mV typical, which is 80% of 290mV) until the first VOC measure or an I<sup>2</sup>C write on VOC[7:0] register is performed. Refer to [Figure 1](#) for the operation of V<sub>SRC</sub> during MPPT.

To adapt the SRC measurement time, if the ATmeas[3](0x07) bit is set, the MAX20361 modulates the measurement time based on the last measured “harvesting count” (HarvCntH/L registers), as specified in [Table 1](#) below.

**Table 1. Measurement Time Based on Harvesting Count**

HARVESTING COUNT VALUE	USED MEASUREMENT TIME
Less than 13	2 x Tmeas
Between 13 and 26	Tmeas
Between 26 and 52	Tmeas / 2
Above 52	Tmeas / 4

The MAX20361 automatically adapts the measurement period when the ATper[2](0x07) bit is set. After power-on reset, the device ignores the first result of harvesting count and stores the second result in the HarvCntH and HarvCntL registers.

If any future harvesting count is greater or lower than the existing stored harvesting count by a factor of 2, the Tper timer is reset and a new VOC measurement is forced immediately.

A VOC measurement can be requested through the `FrcMeas[7](0x07)` bit. The measurement starts within  $T_{meas}$  and results are stored in the `VOCMeas(0x09)` register, and `VOCrdy[3](0x01)` bit is set with the corresponding interrupt.

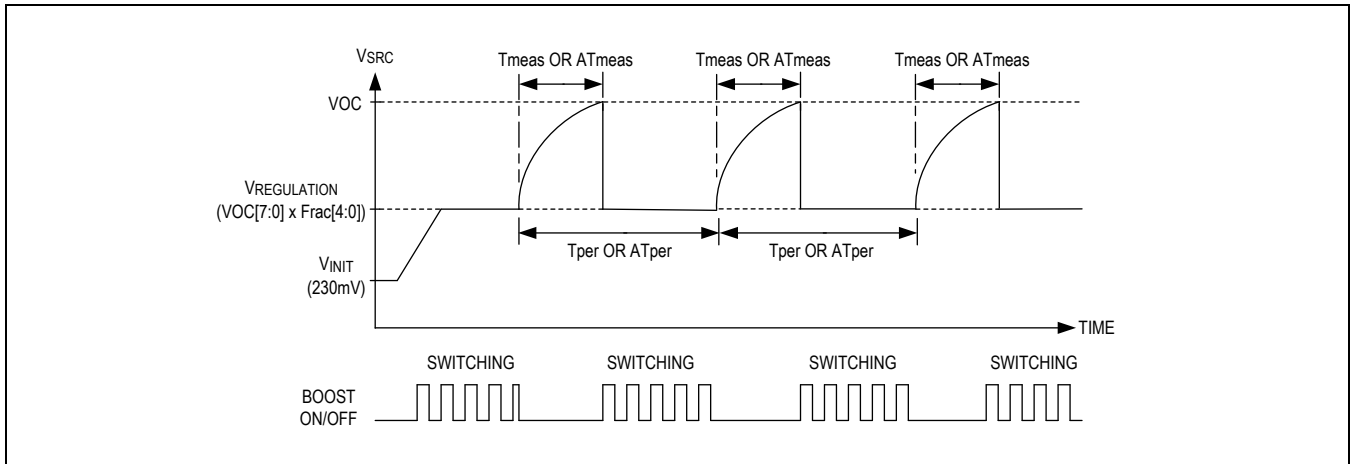


Figure 1. VSRC During Maximum Power Point Tracking

### Low-Light Sleep Mode

To save power, the MAX20361 enters sleep mode when the harvesting meter value is below `SlpThd[7:0](0x0C)` threshold (default `0x00`) or when `VOC[7:0]` is set below the default VOC value by either the VOC measurement or a direct I<sup>2</sup>C write to it. In sleep mode, the internal reference, the boost and the THM monitor are turned off, and SYS and THM are not monitored, and WAKE output is forced low. The MAX20361 remains in sleep mode until the next VOC or THM measurement, or a write to `VOC[7:0]` with a value equal or above the default VOC value. Low-power mode is inhibited during cold startup.

### WAKE Output

Except in Shutdown or Sleep modes, the MAX20361 monitors the SYS output. When SYS is above the WAKE threshold for at least 7 to 8 x  $T_{meas}$  (typ), the WAKE output is asserted (and the `WAKEbSt[0](0x01)` bit is set to 0). When the device goes into Sleep or Shutdown mode, WAKE output is forced low. Refer to [Figure 2](#) for the waveform of  $V_{SYS}$  and WAKE output.

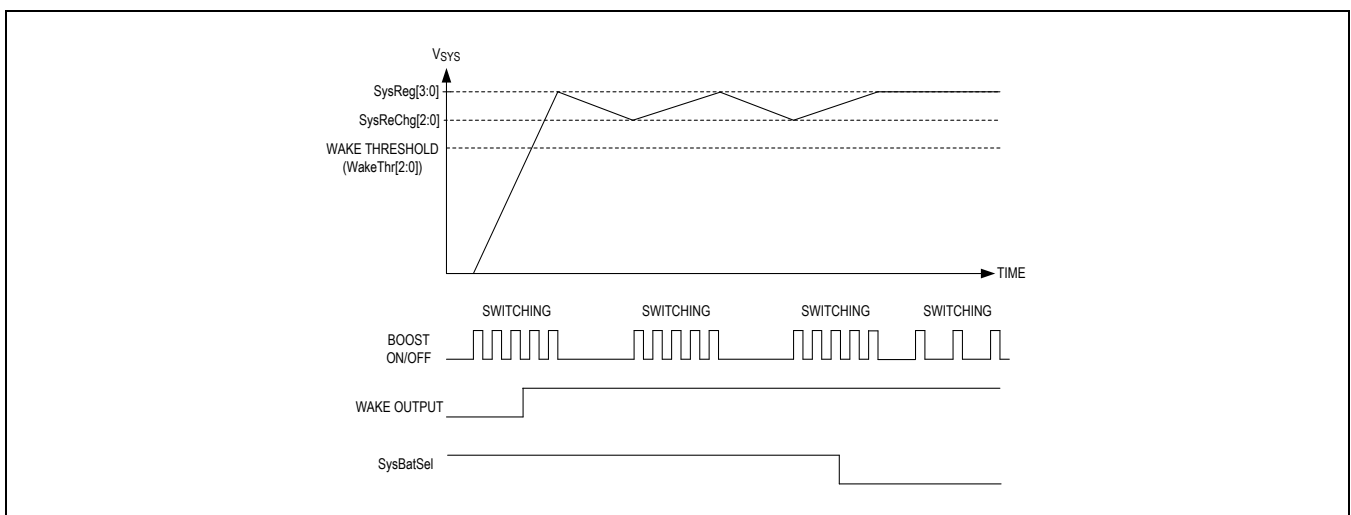


Figure 2. Waveform of VSYS and WAKE Output

## Thermal Monitor

When  $\text{ThmEn}[3](0x08)$  is 1, the MAX20361 monitors the voltage on THM. The device checks  $V_{\text{THM}}$  once if  $\text{FrcTHM}[6](0x07)$  is 1 or periodically every  $T_{\text{per}}[1:0](0x07)$  time if  $\text{THMper}[6](0x05)$  is 1. During that process, the MAX20361 drives REF to 1.2V (typ) for 1ms (typ). The voltage divider, formed by the pullup resistor from THM to REF and the NTC thermistor from THM to ground, provides a voltage at THM proportional to the temperature as a fraction of  $V_{\text{REF}}$ . When  $V_{\text{THM}}$  is above 57.5% of  $V_{\text{REF}}$  or below 18.7% of  $V_{\text{REF}}$ ,  $\text{THMflag}[6](0x01)$  is set and the boost is halted. These thresholds are equivalent to 0°C and 45°C if a 10kΩ NTC thermistor with  $\beta = 3380$  and a 22kΩ pullup resistor are used.

The device also performs a THM check at power-on and on the  $\overline{\text{EN}}$  falling edge. A fault condition is assumed until this first THM check is completed.

## Shutdown

The device enters Shutdown mode when the  $\overline{\text{EN}}$  pin is high or  $\text{DeviceEnb}[1](0x08)$  is 1. In this condition, current consumption is minimized, SYS, THM and SRC are not monitored, WAKE output is forced low and the internal oscillator is turned off. All internal logic, except those values under I<sup>2</sup>C, is held in reset. In the shutdown state, only the POR on  $V_{\text{CC}}$  is active, and the  $V_{\text{CC}}\text{-SYS}$  switch is left open until  $V_{\text{CC}}$  is above the POR threshold. The device exits Shutdown mode when  $\overline{\text{EN}}$  is low and  $\text{DeviceEnb}$  is 0.

## Cold-Startup

The cold start feature of the MAX20361 allows the device to start up even if  $V_{\text{SYS}}$  is below the wake threshold or absent. For a cold startup, the device initially uses a low power charge pump to charge up  $V_{\text{CC}}$  from the power source (such as a solar cell) on SRC while SYS is not charged. Once  $V_{\text{CC}}$  is charged above the POR level, the internal references are enabled and the main boost takes over from the charge pump. As the main boost continues to charge,  $V_{\text{CC}}$  and SYS gets charged above the wake threshold, the  $V_{\text{CC}}\text{-SYS}$  switch is closed and the device is powered from SYS. This completes the cold startup, and the normal operation of the device assumes.

## Source Clamp

By the  $\text{DISintb}[4](0x05)$  bit, the  $\overline{\text{INT}}$  output can be reconfigured as a push-pull  $\text{DISsrc}$  output to drive an external clamp circuit used to prevent overvoltage on SRC. The clamp circuit (see [Figure 3](#)) can be formed by an external nMOS and a load resistor. When the clamp circuit is turned on, the SRC is discharged through the external load resistor. When the boost converter is enabled, the  $\text{DISsrc}$  is driven to divert excess input current in order to let SRC regulate. In shutdown mode, the  $\text{DISsrc}$  output is driven statically high. The  $\text{DISsrc}$  output is disabled during VOC measurement and sleep mode. Refer to the [nMOS Transistor Selection](#) section.

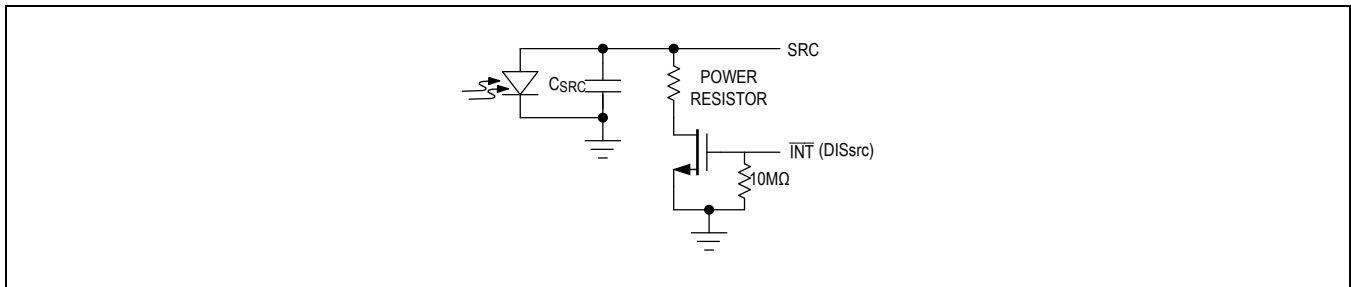


Figure 3. Source Clamp Circuitry

**I<sup>2</sup>C Interface**

The MAX20361 contains an I<sup>2</sup>C-compatible interface for data communication with a host controller (SCL and SDA). The interface supports a clock frequency of up to 400kHz. SCL and SDA require pullup resistors that are connected to a positive supply.

When writing to the MAX20361 using I<sup>2</sup>C, the master sends a START condition (S) followed by the MAX20361 I<sup>2</sup>C address. After the address, the master sends the register address of the register that is to be programmed. The master then ends communication by issuing a STOP condition (P) to relinquish control of the bus, or a REPEATED START condition (Sr) to communicate to another I<sup>2</sup>C slave.

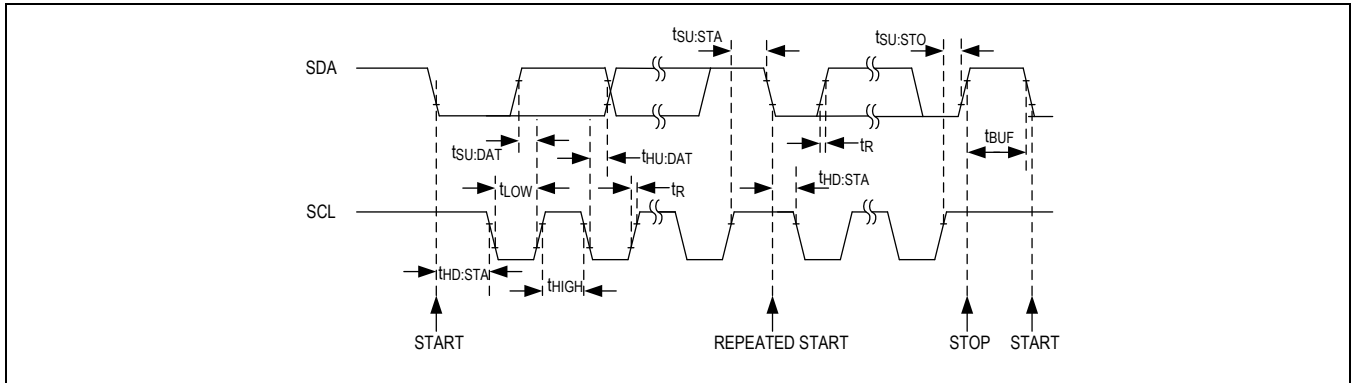


Figure 4. I<sup>2</sup>C Interface Timing

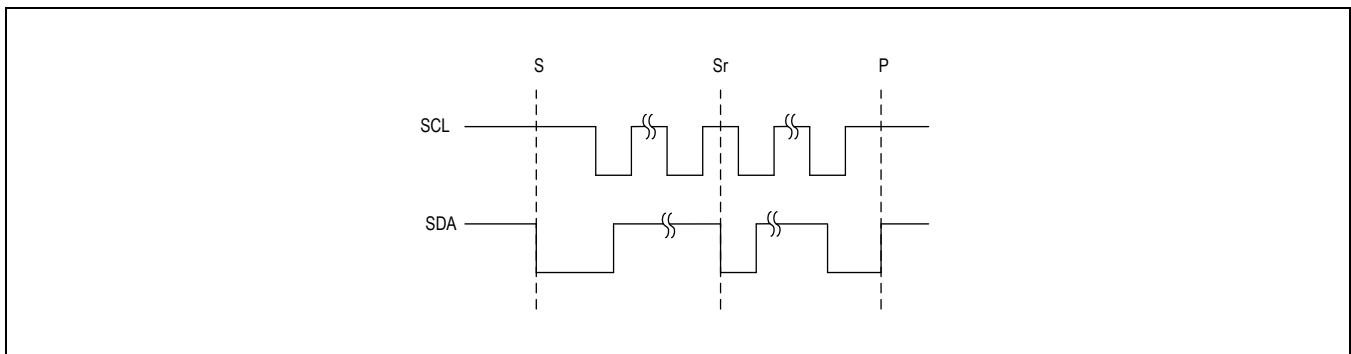


Figure 5. I<sup>2</sup>C START, STOP, and REPEATED START Conditions

**Slave Address**

Set the Read/Write bit high to configure the MAX20361 to read mode (see [Table 2](#)). Set the Read/Write bit low to configure the MAX20361 to write mode. The address is the first byte of information sent to the MAX20361 after the START condition.

**Table 2. I<sup>2</sup>C Slave Addresses**

ADDRESS FORMAT	HEX	BINARY
7-Bit Slave ID	0x15	0010101
Write Address	0x2A	00101010
Read Address	0x2B	00101011



**Bit Transfer**

One data bit is transferred on the rising edge of each SCL clock cycle. The data on SDA must remain stable during the high period of the SCL clock pulse. Changes in SDA while SCL is high and stable are considered control signals (see the Start, Stop, And Repeated Start Conditions section). Both SDA and SCL remain high when the bus is not active.

**Single-Byte Write**

In this operation, the master sends an address and two data bytes to the slave device. The following procedure describes the single byte write operation:

1. The master sends a START condition.
2. The master sends the 7-bit slave address plus a write bit (low).
3. The addressed slave asserts an ACK on the data line.
4. The master sends the 8-bit register address.
5. The slave asserts an ACK on the data line only if the address is valid (NAK if not).
6. The master sends 8 data bits.
7. The slave asserts an ACK on the data line.
8. The master generates a STOP condition.

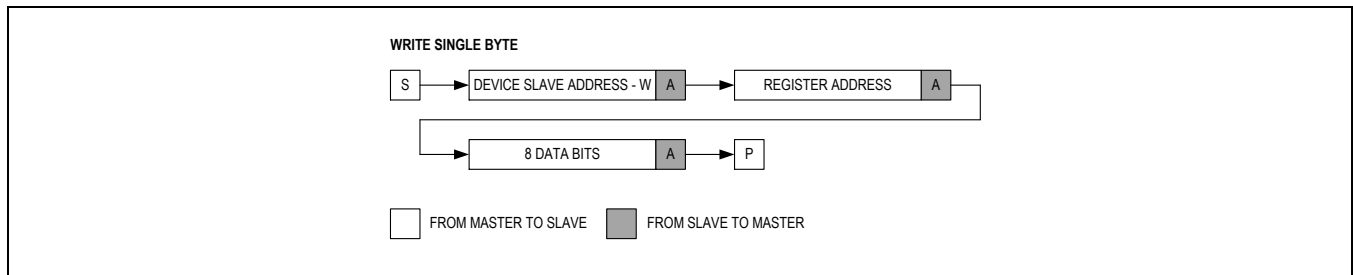


Figure 6. Write Byte Sequence

**Burst Write**

In this operation, the master sends an address and multiple data bytes to the slave device. The slave device automatically increments the register address after each data byte is sent. The following procedure describes the burst write operation:

1. The master sends a START condition.
2. The master sends the 7-bit slave address plus a write bit (low).
3. The addressed slave asserts an ACK on the data line.
4. The master sends the 8-bit register address.
5. The slave asserts an ACK on the data line only if the address is valid (NAK if not).
6. The master sends eight data bits.
7. The slave asserts an ACK on the data line.
8. Repeat 6 and 7 N-1 times.
9. The master generates a STOP condition.

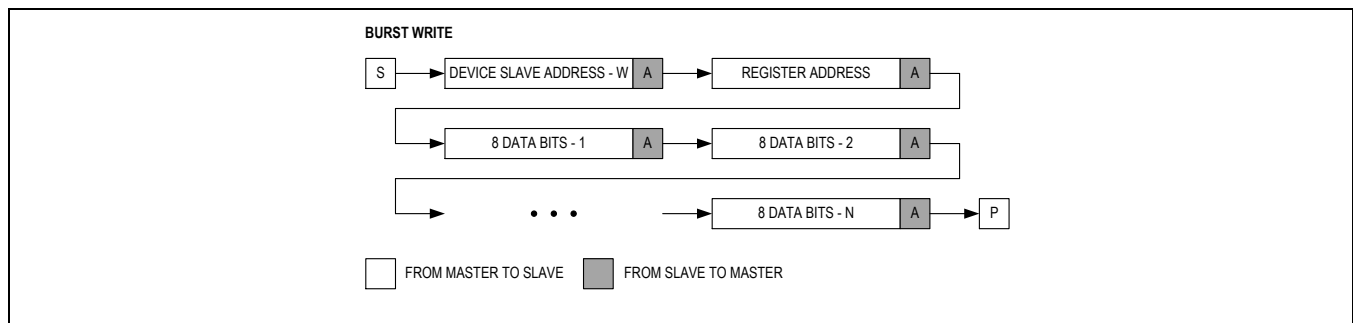


Figure 7. Burst Write Sequence

### Single Byte Read

In this operation, the master sends an address plus two data bytes and receives one data byte from the slave device. The following procedure describes the single byte read operation:

1. The master sends a START condition.
2. The master sends the 7-bit slave address plus a write bit (low).
3. The addressed slave asserts an ACK on the data line.
4. The master sends the 8-bit register address.
5. The slave asserts an ACK on the data line only if the address is valid (NAK if not).
6. The master sends a REPEATED START condition.
7. The master sends the 7-bit slave address plus a read bit (high).
8. The addressed slave asserts an ACK on the data line.
9. The slave sends eight data bits.
10. The master asserts a NACK on the data line.
11. The master generates a STOP condition.

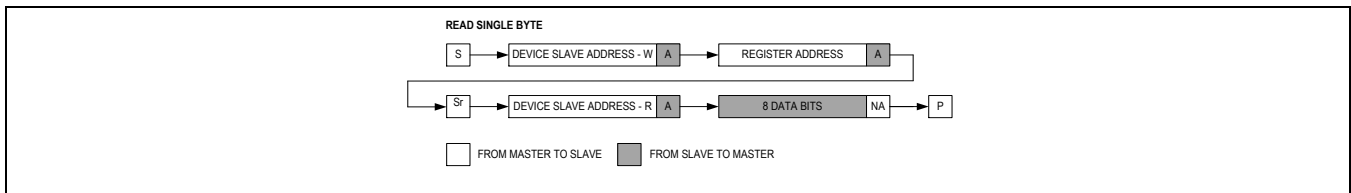


Figure 8. Read Byte Sequence

### Burst Read

In this operation, the master sends an address plus two data bytes and receives multiple data bytes from the slave device. The following procedure describes the burst byte read operation:

1. The master sends a START condition.
2. The master sends the 7-bit slave address plus a write bit (low).
3. The addressed slave asserts an ACK on the data line.
4. The master sends the 8-bit register address.
5. The slave asserts an ACK on the data line only if the address is valid (NAK if not).
6. The master sends a REPEATED START condition.
7. The master sends the 7-bit slave address plus a read bit (high).
8. The slave asserts an ACK on the data line.
9. The slave sends eight data bits.
10. The master asserts an ACK on the data line.
11. Repeat 9 and 10 N-2 times.
12. The slave sends the last eight data bits.
13. The master asserts a NACK on the data line.
14. The master generates a STOP condition.

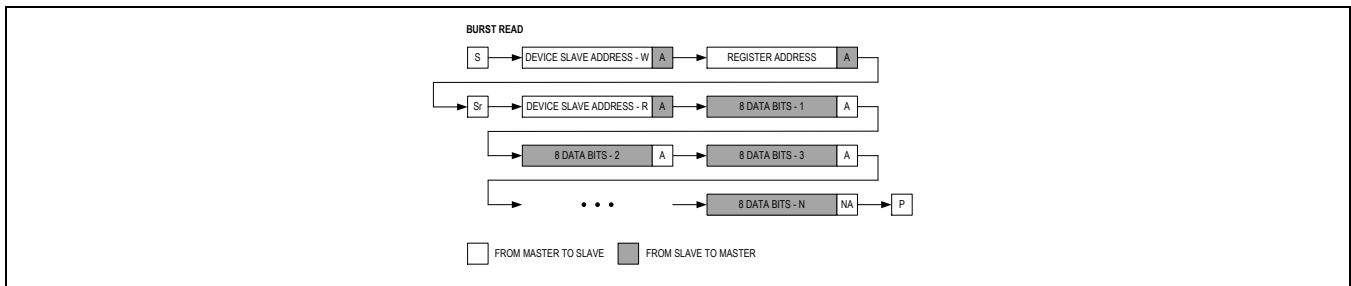


Figure 9. Burst Read Sequence

**Acknowledge Bits**

Data transfers are acknowledged with an acknowledge bit (ACK) or a not-acknowledge bit (NACK). Both the master and the MAX20361 generate ACK bits. To generate an ACK, pull SDA low before the rising edge of the ninth clock pulse and hold it low during the high period of the ninth clock pulse. To generate a NACK, leave SDA high before the rising edge of the ninth clock pulse and leave it high for the duration of the ninth clock pulse. Monitoring for NACK bits allows for detection of unsuccessful data transfers.

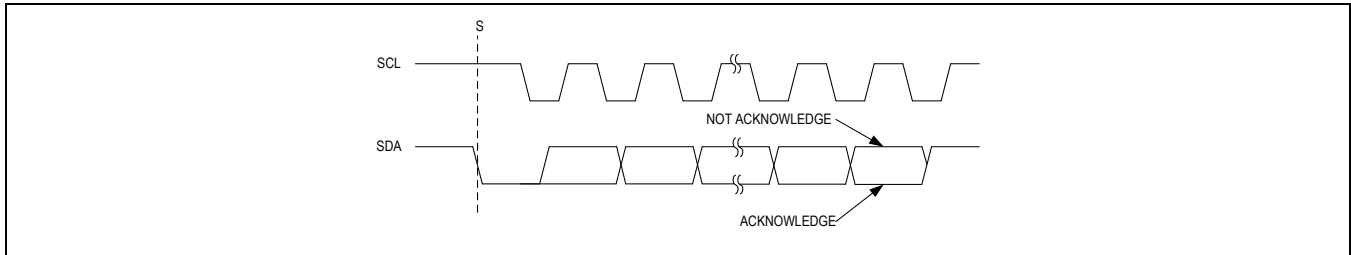


Figure 10. Acknowledge Bits

## Register Map

## MAX20361

ADDRESS	NAME	MSB							LSB
<b>User Registers</b>									
0x00	<a href="#">DeviceID[7:0]</a>	ChipID[3:0]			ChipRev[3:0]				
0x01	<a href="#">Status[7:0]</a>	VOCValid	THMflag	HSYSFlag	HARrdy	VOCrdy	Sleep	ENbStat	WAKEbSt
0x02	<a href="#">Intf[7:0]</a>	–	–	–	HARrdyInt	VOCrdyInt	VOCValidInt	EnbStatInt	WakebStInt
0x03	<a href="#">IntMsk[7:0]</a>	–	–	–	HARrdyMsk	VOCrdyMsk	VOCValidMsk	EnbStatMsk	WakebStMsk
0x04	<a href="#">SysRegCfg[7:0]</a>	SysBatSel	SysReChg[2:0]		SysReg[3:0]				
0x05	<a href="#">WakeCfg[7:0]</a>	VOCper	THMper	–	DISintb	–	WakeThr[2:0]		
0x06	<a href="#">MpptCfg[7:0]</a>	–	–	–	Frac[4:0]				
0x07	<a href="#">MeasCfg[7:0]</a>	FrcMeas	FrcTHM	Tmeas[1:0]		ATmeas	ATper	Tper[1:0]	
0x08	<a href="#">DevCntl[7:0]</a>	–	BSTpk[2:0]		ThmEn	FrcWAKE	DeviceEnb	BoostEnb	
0x09	<a href="#">VOCMeas[7:0]</a>	VOC[7:0]							
0x0A	<a href="#">HarvCntH[7:0]</a>	HARhigh[7:0]							
0x0B	<a href="#">HarvCntL[7:0]</a>	HARlow[7:0]							
0x0C	<a href="#">SleepThd[7:0]</a>	SlpThd[7:0]							

## Register Details

[DeviceID \(0x00\)](#)

BIT	7	6	5	4	3	2	1	0	
<b>Field</b>	ChipID[3:0]				ChipRev[3:0]				
<b>Reset</b>	0x1				0x1				
<b>Access Type</b>	Read Only				Read Only				

BITFIELD	BITS	DESCRIPTION
ChipID	7:4	Chip Identification
ChipRev	3:0	Chip Revision

**Status (0x01)**

BIT	7	6	5	4	3	2	1	0
Field	VOCValid	THMflag	HSYSFlag	HARrdy	VOCrdy	Sleep	ENbStat	WAKEbSt
Reset	0x0	0x0	0x0	0x0	0x0	0x0	0x0	0x0
Access Type	Read Only	Read Only	Read Only	Read Only	Read Only	Read Only	Read Only	Read Only

BITFIELD	BITS	DESCRIPTION
VOCValid	7	Indicates if at least one SRC open-circuit measurement was performed since the last V <sub>CC</sub> POR event. This bit is also reset when a write to the VOCMeas register is performed. This bit is not set after a VOC measurement.  0b0: No SRC open-circuit measurement was performed since the last V <sub>CC</sub> POR event. 0b1: At least one SRC open-circuit measurement was performed since the last V <sub>CC</sub> POR event.
THMflag	6	THM Fault Status  0b0: No THM fault detected 0b1: THM fault detected during the last Tmeas period
HSYSFlag	5	SysReg Overvoltage Fault Flag  0b0: No SysReg flag detected during the last Tmeas period 0b1: SysReg flag detected during the last Tmeas period
HARrdy	4	Harvest Meter Status  0b0: Harvest meter has not been updated since the last read of HarvCntH/L register. 0b1: Harvest meter has been updated since the last read of HarvCntH/L register. <i>Note: this bit is reset when the HarvCntH register is read.</i>
VOCrdy	3	Open-Circuit Voltage Status  0b0: No new open-circuit voltage measurement since the last read of VOCMeas register. 0b1: New open-circuit voltage available since the last read of VOCMeas register.
Sleep	2	Indicates if the Device is in Sleep Mode

BITFIELD	BITS	DESCRIPTION
		0b0: Device is not in sleep mode and it is harvesting. 0b1: Device is in sleep mode to save SYS power (no harvesting).
ENbStat	1	Indicates if the Device is in Shutdown (or Between ENb Pin Input and DeviceEnb Bit)  0b0: ENb pin low and DeviceEnb bit set to 0. 0b1: ENb pin high or DeviceEnb bit set to 1.
WAKEbSt	0	Indicates the Status of the WAKE Pin Output  Only the SYS comparator; does not include the FrcWAKE). This bit is not valid if the Sleep flag is set.  0b0: WAKE pin high (SYS above WakeThr[2:0](0x05) threshold) 0b1: WAKE pin low (SYS below WakeThr[2:0](0x05) threshold)

**Int (0x02)**

BIT	7	6	5	4	3	2	1	0
Field	-	-	-	HARrdyInt	VOCrdyInt	VOCValidInt	EnbStatInt	WakebStInt
Reset	-	-	-	0x0	0x0	0x0	0x0	0x0
Access Type	-	-	-	Read Clears All	Read Clears All	Read Clears All	Read Clears All	Read Clears All

BITFIELD	BITS	DESCRIPTION
HARrdyInt	4	HARrdy Interrupt  0b0: No change in status of HARrdy 0b1: Change in status of HARrdy
VOCrdyInt	3	VOCrdy Interrupt  0b0: No change in status of VOCrdy 0b1: Change in status of VOCrdy
VOCValidInt	2	VOCValid Interrupt  0b0: No change in status of VOCValid 0b1: Change in status of VOCValid
EnbStatInt	1	EnbStat Interrupt  0b0: No change in status of EnbStat 0b1: Change in status of EnbStat

BITFIELD	BITS	DESCRIPTION
WakebStInt	0	WakebSt Interrupt 0b0: No change in status of WakebSt 0b1: Change in status of WakebSt

**IntMsk (0x03)**

BIT	7	6	5	4	3	2	1	0
Field	–	–	–	HARrdyMsk	VOCrdyMsk	VOCValidMsk	EnbStatMsk	WakebStMsk
Reset	–	–	–	0x0	0x0	0x0	0x0	0x0
Access Type	–	–	–	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
HARrdyMsk	4	HARrdyInt Interrupt Mask 0b0: HARrdy interrupt not masked 0b1: HARrdy interrupt masked
VOCrdyMsk	3	VOCrdy Interrupt Mask 0b0: VOCrdy interrupt not masked 0b1: VOCrdy interrupt masked
VOCValidMsk	2	VOCValid Interrupt Mask 0b0: VOCValid interrupt not masked 0b1: VOCValid interrupt masked
EnbStatMsk	1	EnbStat Interrupt Mask 0b0: EnbStat interrupt not masked 0b1: EnbStat interrupt masked
WakebStMsk	0	WakebSt Interrupt Mask 0b0: WakebSt interrupt not masked 0b1: WakebSt interrupt masked

**SysRegCfg (0x04)**

BIT	7	6	5	4	3	2	1	0
Field	SysBatSel	SysReChg[2:0]			SysReg[3:0]			

<b>Reset</b>	0x0	0x0	0x7
<b>Access Type</b>	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
SysBatSel	7	Selects Regulation Mode of SYS 0b0: The boost attempts to regulate the SYS node at $V_{SysReg}$ . 0b1: The boost charges the SYS node until it reaches $V_{SysReg}$ and then switches off until SYS drops to $V_{SysReg} - V_{SysReChg}$ .
SysReChg	6:4	Battery Recharge Threshold Voltage 0b000: 25mV 0b001: 50mV 0b010: 75mV 0b011: 100mV 0b100: 150mV 0b101: 200mV 0b110: 250mV 0b111: 300mV
SysReg	3:0	System Regulation or Battery Termination Voltage On the SYS Node 0b0000: 4.0V ... linear step, 50mV 0b1111: 4.75V

**WakeCfg (0x05)**

BIT	7	6	5	4	3	2	1	0
<b>Field</b>	VOCper	THMper	–	DISintb	–	WakeThr[2:0]		
<b>Reset</b>	0x1	0x0	–	0x0	–	0x7		
<b>Access Type</b>	Write, Read	Write, Read	–	Write, Read	–	Write, Read		

BITFIELD	BITS	DESCRIPTION
VOCper	7	VOC Every Tper (Perform Open Circuit Measurement Every Tper Period) 0b0: VOC measurement performed only on request 0b1: VOC measurement performed every "Tper" time <i>Note: this bit also disables the first VOC measurement after POR.</i>
THMper	6	Thermal Monitor Every Tper



BITFIELD	BITS	DESCRIPTION
		0b0: Thermal monitoring is not performed every Tper time. 0b1: Thermal monitoring is performed every Tper time (only if also ThmEn is set).
DISintb	4	Disable the INTb Pin and Convert It Into a Push-Pull Output to Discharge SRC (Clamp SRC Voltage)  0b0: INTb is an open-drain output for interrupt. 0b1: INTb becomes a DISsrc push-pull output (to Vcc). When high, discharge SRC through a resistor.
WakeThr	2:0	Wake Threshold. When BAT reaches this voltage, the device asserts the WAKE output.  0b000: 3.0V 0b001: 3.1V 0b010: 3.2V 0b011: 3.3V 0b100: 3.4V 0b101: 3.5V 0b110: 3.6V 0b111: 3.7V

**MpptCfg (0x06)**

BIT	7	6	5	4	3	2	1	0
Field	–	–	–	Frac[4:0]				
Reset	–	–	–	0x19				
Access Type	–	–	–	Write, Read				

BITFIELD	BITS	DESCRIPTION
Frac	4:0	Set the Fraction of the Open-Circuit Voltage to which the Boost Converter Attempts to Regulate at Vsrc.  0b00000: 42.5% ...Linear scale, 1.5% / LSB 0b11111: 89.0%

**MeasCfg (0x07)**

BIT	7	6	5	4	3	2	1	0
Field	FrcMeas	FrcTHM	Tmeas[1:0]		ATmeas	ATper	Tper[1:0]	
Reset	0x0	0x0	0x0		0x1	0x1	0x2	

<b>Access Type</b>	Write Only Clears All	Write Only Clears All	Write, Read	Write, Read	Write, Read	Write, Read
--------------------	--------------------------	--------------------------	-------------	-------------	-------------	-------------

BITFIELD	BITS	DESCRIPTION
FrcMeas	7	Writing 1 to this bit forces a measure of an open-circuit voltage measurement (if NoVOCMeas is 0) at SRC. This bit is automatically forced to 0. The measurement algorithm and time for VOC at SRC is set by ATmeas and Tmeas bits. Until FrcMeas is set, the VOC register should not be written.
FrcTHM	6	Writing 1 to this bit forces a measure of thermal monitoring (only if ThmEn bit is 1). This bit is automatically forced to 0.
Tmeas	5:4	Set the Measurement Time  0b00: 50ms 0b01: 100ms 0b10: 250ms 0b11: 500ms
ATmeas	3	Set the Algorithm Used to Adjust the Settling Time for VOC Measure  0b0: The settling time is fixed and set by Tmeas bits. 0b1: Adaptive measuring time based on the current HarvCnt value, from Tmeas / 4 to 2 x Tmeas.
ATper	2	Adaptive Period (Valid Only If Tper < 0b11)  0b0: Disabled 0b1: Store HarvCntH/L after 2 x Tmeas (or more, see text). A measure is forced (if not in sleep) when the future harvesting value is greater or lower than the existing stored measurement by a factor of 2 (future HarvCnt/current HarvCnt < 0.5 or future HarvCnt/current HarvCnt > 2).
Tper	1:0	Set the Period of Automatic Measurement  0b00: 64 x Tmeas 0b01: 128 x Tmeas 0b10: 256 x Tmeas 0b11: Disabled  When "Disabled", VOC and THM are never automatically read. The system should periodically use the FrcMeas and FrcTHM bit to force measurements.

**DevCntl (0x08)**

<b>BIT</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
<b>Field</b>	–	BSTpk[2:0]			ThmEn	FrcWAKE	DeviceEnb	BoostEnb

<b>Reset</b>	–	0x3	0x0	0x0	0x0	0x0
<b>Access Type</b>	–	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
BSTpk	6:4	Select the Peak Current for The Boost Converter  0b000: 90mA 0b001: 120mA 0b010: 145mA 0b011: 180mA 0b100: 285mA 0b101: 355mA 0b110: 470mA 0b111: 715mA
ThmEn	3	Thermal Monitoring Enable Bit  0b0: Thermal monitoring is not enabled, and temperature does not affect boost operation. 0b1: Thermal monitoring is enabled. The thermal monitoring circuit on every Tper period (if THMper is set) or when FrcTHM is set, and if necessary, turns off the boost converter to halt charging of the battery.
FrcWAKE	2	I <sup>2</sup> C Control of The WAKE Output  0b0: WAKE output is controlled by the WAKE comparator. 0b1: WAKE output is high regardless of the status of the WAKE comparator.
DeviceEnb	1	I <sup>2</sup> C Control of Device Enable  0b0: Device enable is controlled by the ENb pin. 0b1: Device disabled regardless of the status of the ENb pin.
BoostEnb	0	I <sup>2</sup> C Enable of the Boost Converter  0b0: Boost converter is controlled by the internal digital logic. 0b1: Boost converter is disabled regardless of the internal digital logic.

**VOCMeas (0x09)**

BIT	7	6	5	4	3	2	1	0
<b>Field</b>	VOC[7:0]							
<b>Reset</b>	0x1D							
<b>Access Type</b>	Write, Read							

BITFIELD	BITS	DESCRIPTION
VOC	7:0	<p>Most Recent Result of Open-Circuit Voltage Measurement at SRC. This value can be read anytime without triggering the FrcMeas bit.</p> <p>0: 0V ... 255: 2.55V</p> <p>This register can be written to override the VOC measure. Every time the VOC register is updated to value below the default VOC value (either by VOC measurement or by I<sup>2</sup>C writing), the boost is halted and sleep mode is entered to save power, until the next VOC measurement (upon Tper or FrcVOC) or until VOC is written to a higher value.</p> <p>The VOC register should not be written to when FrcMeas is set.</p>

**HarvCntH (0x0A)**

BIT	7	6	5	4	3	2	1	0
Field	HARhigh[7:0]							
Reset	0x0							
Access Type	Read Only							

BITFIELD	BITS	DESCRIPTION
HARhigh	7:0	<p>Return the Number of “LX Pulses” of the Boost, the only 8 MSBits of Counter. This number is valid only when SYS is above the WAKE threshold. This number is proportional to the SYS “charging” current.</p> <p>When the counter overflows, it returns to 0xFFFF.</p> <p><i>Note: the HarvCnt is not updated when the device is in sleep mode.</i></p>

**HarvCntL (0x0B)**

BIT	7	6	5	4	3	2	1	0
Field	HARlow[7:0]							
Reset	0x0							
Access Type	Read Only							

BITFIELD	BITS	DESCRIPTION
HARlow	7:0	<p>Return the Number of “LX Pulses” of the Boost, the only 8 LSBs of the Counter. This number is valid only when SYS is above WAKE threshold. This number is</p>

BITFIELD	BITS	DESCRIPTION
		proportional to the SYS “charging” current. When the counter overflows, it returns to 0xFFFF.

**SleepThd (0x0C)**

BIT	7	6	5	4	3	2	1	0
Field	SlpThd[7:0]							
Reset	0x0							
Access Type	Write, Read							

BITFIELD	BITS	DESCRIPTION
SlpThd	7:0	The “Harvesting Count” Threshold to Enter Sleep Mode Until the Next VOC Measure. This value is compared with the HarvCnt (the bits returned in registers HarvCntH/L). This feature is ignored if SlpThd = 0.

## Applications Information

### Inductor Selection

The operation of the boost regulator requires a properly sized inductor with the appropriate value. The inductor must be connected between SRC (pin B1) and LX (pin C1). The boost regulator performance, such as efficiency, is optimized to control the switching behavior with a nominal inductance of  $4.7\mu\text{H} \pm 20\%$ . The inductor must have low series resistance (DCR) to minimize loss and maintain high efficiency. The recommended inductance range is between  $4.7\mu\text{H}$  and  $22\mu\text{H}$ . Refer to [Table 3](#) for a list of recommended inductors.

**Table 3. Boost Regulator Inductor Recommendation**

INDUCTANCE ( $\mu\text{H}$ )	DIMENSIONS (mm)	PART NUMBER	MANUFACTURER
4.7	2 x 1.6 x 1.2	DFE201612E-4R7M=P2	Murata
4.7	2.5 x 2 x 1	DFE252010F-4R7M=P2	Murata
4.7	4.8 x 4.8 x 3	744043004	Würth
15	3.8 x 3.8 x 1.8	744031150	Würth
22	7.3 x 7.3 x 4.5	7447779122	Würth

### Capacitor Selection

All selected capacitors need to have low leakage. Any leakage from capacitors contributes to the loss of efficiency, increases the quiescent current, and reduces the effectiveness of the energy harvesting process. The capacitance specified in the data sheet refers to the effective capacitance after accounting for the voltage derating. Small ceramic capacitors tend to lose effective capacitance very quickly as DC bias is increased. Ensure that DC degradation would not affect the effective capacitance of bypass capacitors located at  $V_{\text{CC}}$ , SRC, and SYS.

#### SRC Capacitance

The capacitor connected to pin SRC ( $C_{\text{SRC}}$ ) is used to initially store energy from the harvesting input source. The output capacitance of the input energy source determines the value of the SRC capacitor. A minimum effective capacitance of  $10\mu\text{F}$  is recommended. Larger capacitance ( $22\mu\text{F}$ ) is recommended for  $10\mu\text{H}$  and  $22\mu\text{H}$  inductances.

#### SYS and $V_{\text{CC}}$ Capacitance

Connect a bypass capacitor to the system output ( $C_{\text{SYS}}$ ) of the MAX20361. This capacitor needs to have low equivalent series resistance (ESR). An effective capacitance of  $1\mu\text{F}$  is recommended.

### nMOS Transistor Selection

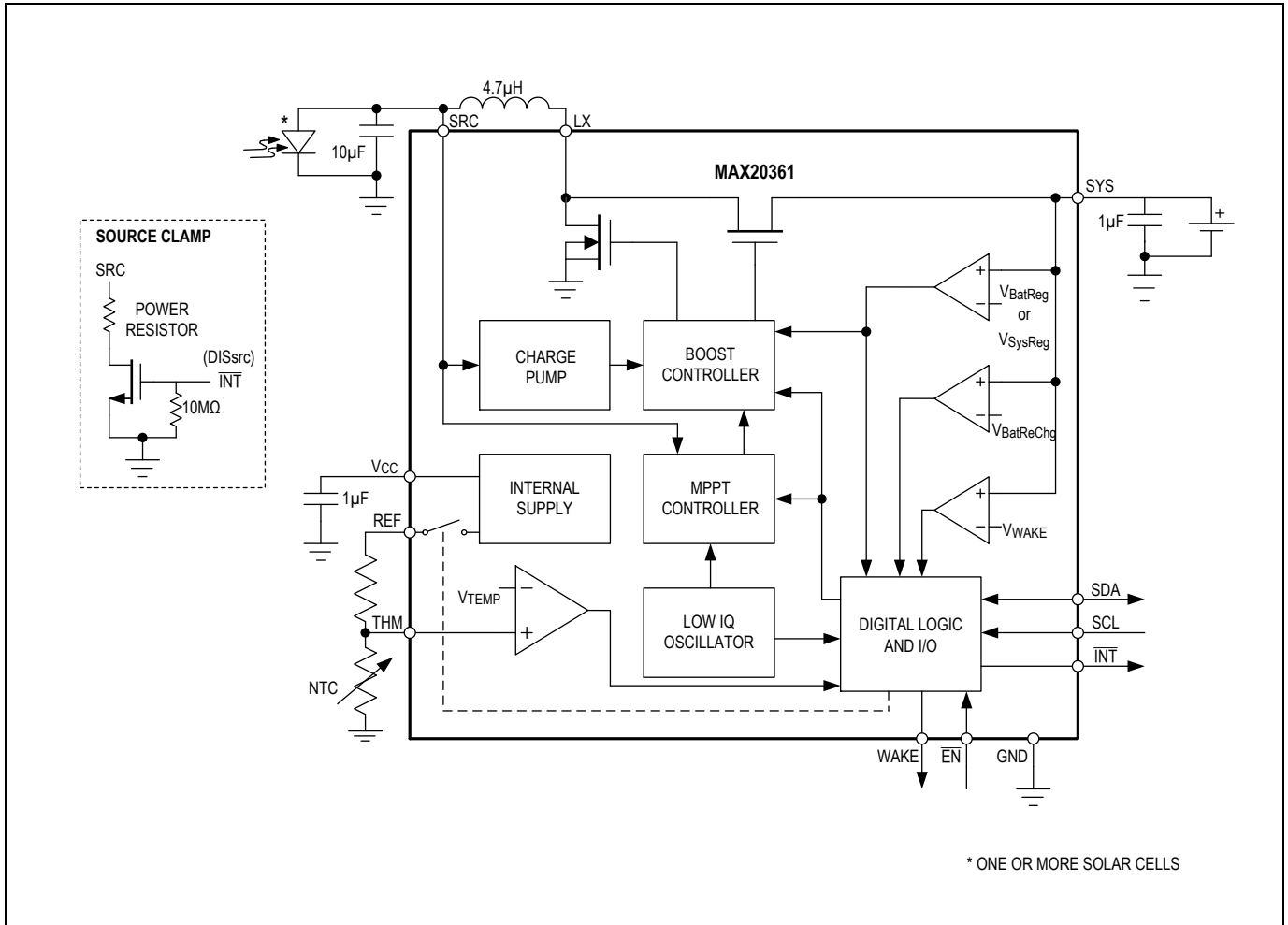
See [Table 4](#) for a list of recommended nMOS transistors used for the source clamp circuitry. The gate to source threshold voltage and drive voltage must be lower than 2V for this application.

**Table 4. nMOS Transistor Recommendation**

MANUFACTURER	PART NUMBER	DRAIN-TO-SOURCE VOLTAGE (V)	CONTINUOUS-DRAIN CURRENT (A)	GATE-TO-SOURCE VOLTAGE THRESHOLD (V)	DRIVE VOLTAGE (V)
Diodes Incorporated	DMN2230U-7	20	2	1	1.8
ON Semiconductor	FDMA410NZ	20	9.5	1	1.5
Diodes Incorporated	DMC1028UVT-7	12	6.1	1	1.8

Typical Application Circuits

Solar Application Circuit



## Register Bit Default Values

[Table 5](#) shows the default settings for different versions. These default values are OTP programmable. Some bits can be changed through the I<sup>2</sup>C interface after power-up, while some bits are set through OTP.

**Table 5. Device Default Settings**

REGISTER BITS	MAX20361A	MAX20361B	MAX20361C
SysBatSel	0	0	0
SysReChg [2:0]	25mV	25mV	25mV
SysReg [3:0]	4.35V	4.1V	4.1V
BSTpk0[2:0]	3	3	3
ThmEn	Disabled	Enabled	Disabled
WakeThr [2:0]	3.7V	3.1V	3.7V
Frac [4:0]	80.0%	80.0%	80.0%
VOCper	Enabled	Enabled	Enabled
THMper	Disabled	Enabled	Disabled
Tmeas[1:0]	50ms	50ms	50ms
ATmeas	1	1	1
ATper	Enabled	Enabled	Enabled
Tper [1:0]	0b10	0b10	0b10
VOC [7:0]	0.29V	0V	0.29V
SlpThd [7:0]	0V	0V	0V

## Register Default Values

[Table 6](#) shows the default values of all the registers.

**Table 6. I<sup>2</sup>C Direct Register Defaults**

REGISTER ADDRESS	REGISTER NAME	MAX20361A	MAX20361B	MAX20361C
0x00	DeviceID	0x11	0x11	0x11
0x01	Status	0x00	0x00	0x00
0x02	Int	0x00	0x00	0x00
0x03	IntMsk	0x00	0x00	0x00
0x04	SysRegCfg	0x07	0x02	0x02
0x05	WakeCfg	0x87	0xC1	0x87
0x06	MpptCfg	0x19	0x19	0x19
0x07	MeasCfg	0x0E	0x0E	0x0E
0x08	DevCntl	0x30	0x38	0x30
0x09	VOCMeas	0x1D	0x00	0x1D
0x0A	HarvCntH	0x00	0x00	0x00
0x0B	HarvCntL	0x00	0x00	0x00
0x0C	SleepThd	0x00	0x00	0x00



**Ordering Information**

<b>PART NUMBER</b>	<b>TEMP RANGE</b>	<b>PIN-PACKAGE</b>
MAX20361AEWC+	-40°C to +85°C	12 WLP
MAX20361AEWC+T	-40°C to +85°C	12 WLP
MAX20361BEWC+	-40°C to +85°C	12 WLP
MAX20361BEWC+T	-40°C to +85°C	12 WLP
MAX20361CEWC+	-40°C to +85°C	12 WLP
MAX20361CEWC+T	-40°C to +85°C	12 WLP

+Denotes a lead(Pb)-free/RoHS-compliant package.

T = Tape and reel.

**Revision History**

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	9/20	Release for Market Intro	—
1	9/20	Updated the General Description, Benefits and Features, Electrical Characteristics, and Detailed Description	1, 4, 13
2	12/22	Added Table 5 and Table 6. Added MAX20361BEWC+ and MAX20361BEWC+T in Ordering Information	31, 32
3	3/23	Updated Maximum Power Point Tracking section, Low-Light Sleep Mode section, and VOC register. Added MAX20361CEWC+ and MAX20361CEWC+T in Table 5 and Table 6 and Ordering Information.	13, 14, 28, 32, 33

